

Docket No.: 50090-339

DATENT

**PATENT** 

4/29/03

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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Takashi INBE

Serial No.: 09/960,356

: Group Art Unit: 2811

Filed: September 24, 2001

Examiner: Gene Munson

For:

SEMICONDUCTOR DEVICE FOR DETECTING NEUTRON, AND METHOD

FOR THE FABRICATION

## PRELIMINARY AMENDMENT

Commissioner for Patents Washington, DC 20231

Sir:

The following amendments and remarks are submitted in conjunction with the filing of a Request for Continued Examination in response to the Office Action dated November 18, 2002.

This amendment is presented in accord with the Waiver of 37 C.F.R. § 1.121 published in the Pre-OG notices on January 31, 2003.